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"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded -</u> <u>Microcontrollers</u>"

Details

E·XFI

Product Status	Active
Core Processor	ARM® Cortex®-M3
Core Size	32-Bit Single-Core
Speed	67MHz
Connectivity	I ² C, LINbus, SPI, UART/USART, USB
Peripherals	CapSense, DMA, LCD, POR, PWM, WDT
Number of I/O	62
Program Memory Size	256КВ (256К х 8)
Program Memory Type	FLASH
EEPROM Size	2K x 8
RAM Size	64K x 8
Voltage - Supply (Vcc/Vdd)	1.71V ~ 5.5V
Data Converters	A/D 2x12b; D/A 4x8b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	100-LQFP
Supplier Device Package	100-TQFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/cy8c5668axi-lp010

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong







Figure 4-1. ARM Cortex-M3 Block Diagram

The Cortex-M3 CPU subsystem includes these features:

- ARM Cortex-M3 CPU
- Programmable Nested Vectored Interrupt Controller (NVIC), tightly integrated with the CPU core
- Full featured debug and trace modules, tightly integrated with the CPU core
- Up to 256 KB of flash memory, 2 KB of EEPROM, and 64 KB of SRAM
- Cache controller
- Peripheral HUB (PHUB)
- DMA controller
- External Memory Interface (EMIF)

4.1.1 Cortex-M3 Features

The Cortex-M3 CPU features include:

- 4 GB address space. Predefined address regions for code, data, and peripherals. Multiple buses for efficient and simultaneous accesses of instructions, data, and peripherals.
- The Thumb[®]-2 instruction set, which offers ARM-level performance at Thumb-level code density. This includes 16-bit and 32-bit instructions. Advanced instructions include:
 - Bit-field control
 - Hardware multiply and divide
 - Saturation
 - If-Then
 - Wait for events and interrupts
 - Exclusive access and barrier
 - Special register access
 - The Cortex-M3 does not support ARM instructions.
- Bit-band support for the SRAM region. Atomic bit-level write and read operations for SRAM addresses.
- Unaligned data storage and access. Contiguous storage of data of different byte lengths.
- Operation at two privilege levels (privileged and user) and in two modes (thread and handler). Some instructions can only be executed at the privileged level. There are also two stack pointers: Main (MSP) and Process (PSP). These features support a multitasking operating system running one or more user-level processes.
- Extensive interrupt and system exception support.



6. System Integration

6.1 Clocking System

The clocking system generates, divides, and distributes clocks throughout the PSoC system. For the majority of systems, no external crystal is required. The IMO and PLL together can generate up to a 80 MHz clock, accurate to $\pm 1\%$ over voltage and temperature. Additional internal and external clock sources allow each design to optimize accuracy, power, and cost. All of the system clock sources can be used to generate other clock frequencies in the 16-bit clock dividers and UDBs for anything the user wants, for example a UART baud rate generator.

Clock generation and distribution is automatically configured through the PSoC Creator IDE graphical interface. This is based on the complete system's requirements. It greatly speeds the design process. PSoC Creator allows designers to build clocking systems with minimal input. The designer can specify desired clock frequencies and accuracies, and the software locates or builds a clock that meets the required specifications. This is possible because of the programmability inherent in PSoC. Key features of the clocking system include:

- Seven general purpose clock sources
 - □ 3- to 74-MHz IMO, ±1% at 3 MHz
 - □ 4- to 25-MHz External Crystal Oscillator (MHzECO)
 - Clock doubler provides a doubled clock frequency output for the USB block, see USB Clock Domain on page 26
 - DSI signal from an external I/O pin or other logic
 - 24- to 80-MHz fractional Phase-Locked Loop (PLL) sourced from IMO, MHzECO, or DSI
 - Clock Doubler
 - □ 1-kHz, 33-kHz, 100-kHz ILO for Watch Dog Timer (WDT) and Sleep Timer
 - □ 32.768-kHz External Crystal Oscillator (kHzECO) for Real Time Clock (RTC)
- IMO has a USB mode that auto locks to USB bus clock requiring no external crystal for USB. (USB equipped parts only)
- Independently sourced clock in all clock dividers
- Eight 16-bit clock dividers for the digital system
- Four 16-bit clock dividers for the analog system
- Dedicated 16-bit divider for the CPU bus and CPU clock
- Automatic clock configuration in PSoC Creator

Source	Fmin	Tolerance at Fmin	Fmax	Tolerance at Fmax	Startup Time
IMO	3 MHz	±1% over voltage and temperature	74 MHz	±7%	13 µs max
MHzECO	4 MHz	Crystal dependent	25 MHz	Crystal dependent	5 ms typ, max is crystal dependent
DSI	0 MHz	Input dependent	33 MHz	Input dependent	Input dependent
PLL	24 MHz	Input dependent	80 MHz	Input dependent	250 µs max
Doubler	12 MHz	Input dependent	48 MHz	Input dependent	1 µs max
ILO	1 kHz	-50%, +100%	100 kHz	-55%, +100%	15 ms max in lowest power mode
kHzECO	32 kHz	Crystal dependent	32 kHz	Crystal dependent	500 ms typ, max is crystal dependent

Table 6-1. Oscillator Summary



Note IPOR disables the watchdog function. The program must enable the watchdog function at an appropriate point in the code by setting a register bit. When this bit is set, it cannot be cleared again except by an IPOR power on reset event.

6.4 I/O System and Routing

PSoC I/Os are extremely flexible. Every GPIO has analog and digital I/O capability. All I/Os have a large number of drive modes, which are set at POR. PSoC also provides up to four individual I/O voltage domains through the VDDIO pins.

There are two types of I/O pins on every device; those with USB provide a third type. Both General Purpose I/O (GPIO) and Special I/O (SIO) provide similar digital functionality. The primary differences are their analog capability and drive strength. Devices that include USB also provide two USBIO pins that support specific USB functionality as well as limited GPIO capability.

All I/O pins are available for use as digital inputs and outputs for both the CPU and digital peripherals. In addition, all I/O pins can generate an interrupt. The flexible and advanced capabilities of the PSoC I/O, combined with any signal to any pin routability, greatly simplify circuit design and board layout. All GPIO pins can be used for analog input, CapSense^[9], and LCD segment drive, while SIO pins are used for voltages in excess of VDDA and for programmable output voltages.

- Features supported by both GPIO and SIO:
- User programmable port reset state
- Separate I/O supplies and voltages for up to four groups of I/O
- Digital peripherals use DSI to connect the pins
- Input or output or both for CPU and DMA
- Eight drive modes

- Every pin can be an interrupt source configured as rising edge, falling edge or both edges. If required, level sensitive interrupts are supported through the DSI
- Dedicated port interrupt vector for each port
- Slew rate controlled digital output drive mode
- Access port control and configuration registers on either port basis or pin basis
- Separate port read (PS) and write (DR) data registers to avoid read modify write errors
- Special functionality on a pin by pin basis
- Additional features only provided on the GPIO pins:
 - LCD segment drive on LCD equipped devices CapSense^[9]
 - Analog input and output capability
 - □ Continuous 100 µA clamp current capability
 - □ Standard drive strength down to 1.71 V
- Additional features only provided on SIO pins:
 - Higher drive strength than GPIO
 - Hot swap capability (5 V tolerance at any operating VDD)
 - \blacksquare Programmable and regulated high input and output drive levels down to 1.2 V
 - No analog input, CapSense, or LCD capability
 - Overvoltage tolerance up to 5.5 V
 - SIO can act as a general purpose analog comparator
- USBIO features:
 - □ Full speed USB 2.0 compliant I/O
 - Highest drive strength for general purpose use
- Input, output, or both for CPU and DMA
- Input, output, or both for digital peripherals
- Digital output (CMOS) drive mode
- Each pin can be an interrupt source configured as rising edge, falling edge, or both edges

^{9.} GPIOs with opamp outputs are not recommended for use with CapSense.



The USBIO pins (P15[7] and P15[6]), when enabled for I/O mode, have limited drive mode control. The drive mode is set using the PRT15.DM0[7, 6] register. A resistive pull option is also available at the USBIO pins, which can be enabled using the PRT15.DM1[7, 6] register. When enabled for USB mode, the drive mode control has no impact on the configuration of the USB pins. Unlike the GPIO and SIO configurations, the port wide configuration registers do not configure the USB drive mode bits. Table 6-7 shows the drive mode configuration for the USBIO pins.

PRT15.DM1[7,6] Pull up enable	PRT15.DM0[7,6] Drive Mode enable	PRT15.DR[7,6] = 1	PRT15.DR[7,6] = 0	Description
0	0	High Z	Strong Low	Open Drain, Strong Low
0	1	Strong High	Strong Low	Strong Outputs
1	0	Res High (5k)	Strong Low	Resistive Pull Up, Strong Low
1	1	Strong High	Strong Low	Strong Outputs

High impedance analog

The default reset state with both the output driver and digital input buffer turned off. This prevents any current from flowing in the I/O's digital input buffer due to a floating voltage. This state is recommended for pins that are floating or that support an analog voltage. High impedance analog pins do not provide digital input functionality.

To achieve the lowest chip current in sleep modes, all I/Os must either be configured to the high impedance analog mode, or have their pins driven to a power supply rail by the PSoC device or by external circuitry.

High impedance digital

The input buffer is enabled for digital signal input. This is the standard high impedance (HiZ) state recommended for digital inputs.

Resistive pull up or resistive pull down

Resistive pull up or pull down, respectively, provides a series resistance in one of the data states and strong drive in the other. Pins can be used for digital input and output in these modes. Interfacing to mechanical switches is a common application for these modes. Resistive pull up and pull down are not available with SIO in regulated output mode.

Open drain, drives high and open drain, drives low

Open drain modes provide high impedance in one of the data states and strong drive in the other. Pins can be used for digital input and output in these modes. A common application for these modes is driving the I^2C bus signal lines.

Strong drive

Provides a strong CMOS output drive in either high or low state. This is the standard output mode for pins. Strong Drive mode pins must not be used as inputs under normal circumstances. This mode is often used to drive digital output signals or external FETs.

Resistive pull up and pull down

Similar to the resistive pull up and resistive pull down modes except the pin is always in series with a resistor. The high data state is pull up while the low data state is pull down. This mode is most often used when other signals that may cause shorts can drive the bus. Resistive pull up and pull down are not available with SIO in regulated output mode.

6.4.2 Pin Registers

Registers to configure and interact with pins come in two forms that may be used interchangeably.

All I/O registers are available in the standard port form, where each bit of the register corresponds to one of the port pins. This register form is efficient for quickly reconfiguring multiple port pins at the same time.

I/O registers are also available in pin form, which combines the eight most commonly used port register bits into a single register for each pin. This enables very fast configuration changes to individual pins with a single register write.

6.4.3 Bidirectional Mode

High speed bidirectional capability allows pins to provide both the high impedance digital drive mode for input signals and a second user selected drive mode such as strong drive (set using PRTxDM[2:0] registers) for output signals on the same pin, based on the state of an auxiliary control bus signal. The bidirectional capability is useful for processor busses and communications interfaces such as the SPI Slave MISO pin that requires dynamic hardware control of the output buffer.

The auxiliary control bus routes up to 16 UDB or digital peripheral generated output enable signals to one or more pins.

6.4.4 Slew Rate Limited Mode

GPIO and SIO pins have fast and slow output slew rate options for strong and open drain drive modes, not resistive drive modes. Because it results in reduced EMI, the slow edge rate option is recommended for signals that are not speed critical, generally less than 1 MHz. The fast slew rate is for signals between 1 MHz and 33 MHz. The slew rate is individually configurable for each pin, and is set by the PRTxSLW registers.

6.4.5 Pin Interrupts

All GPIO and SIO pins are able to generate interrupts to the system. All eight pins in each port interface to their own Port Interrupt Control Unit (PICU) and associated interrupt vector. Each pin of the port is independently configurable to detect rising edge, falling edge, both edge interrupts, or to not generate an interrupt.

Depending on the configured mode for each pin, each time an interrupt event occurs on a pin, its corresponding status bit of the interrupt status register is set to "1" and an interrupt request is sent to the interrupt controller. Each PICU has its own interrupt



7.3 UDB Array Description

Figure 7-7 shows an example of a 16 UDB array. In addition to the array core, there are a DSI routing interfaces at the top and bottom of the array. Other interfaces that are not explicitly shown include the system interfaces for bus and clock distribution. The UDB array includes multiple horizontal and vertical routing channels each comprised of 96 wires. The wire connections to UDBs, at horizontal/vertical intersection and at the DSI interface are highly permutable providing efficient automatic routing in PSoC Creator. Additionally the routing allows wire by wire segmentation along the vertical and horizontal routing to further increase routing flexibility and capability.

Figure 7-7. Digital System Interface Structure



7.3.1 UDB Array Programmable Resources

Figure 7-8 shows an example of how functions are mapped into a bank of 16 UDBs. The primary programmable resources of the UDB are two PLDs, one datapath and one status/control register. These resources are allocated independently, because they have independently selectable clocks, and therefore unused blocks are allocated to other unrelated functions.

An example of this is the 8-bit Timer in the upper left corner of the array. This function only requires one datapath in the UDB, and therefore the PLD resources may be allocated to another function. A function such as a Quadrature Decoder may require more PLD logic than one UDB can supply and in this case can utilize the unused PLD blocks in the 8-bit Timer UDB. Programmable resources in the UDB array are generally homogeneous so functions can be mapped to arbitrary boundaries in the array.

Figure 7-8. Function Mapping Example in a Bank of UDBs



7.4 DSI Routing Interface Description

The DSI routing interface is a continuation of the horizontal and vertical routing channels at the top and bottom of the UDB array core. It provides general purpose programmable routing between device peripherals, including UDBs, I/Os, analog peripherals, interrupts, DMA and fixed function peripherals.

Figure 7-9 illustrates the concept of the digital system interconnect, which connects the UDB array routing matrix with other device peripherals. Any digital core or fixed function peripheral that needs programmable routing is connected to this interface.

Signals in this category include:

- Interrupt requests from all digital peripherals in the system.
- DMA requests from all digital peripherals in the system.
- Digital peripheral data signals that need flexible routing to I/Os.
- Digital peripheral data signals that need connections to UDBs.
- Connections to the interrupt and DMA controllers.
- Connection to I/O pins.
- Connection to analog system digital signals.





Figure 7-9. Digital System Interconnect

Interrupt and DMA routing is very flexible in the CY8C56LP programmable architecture. In addition to the numerous fixed function peripherals that can generate interrupt requests, any data signal in the UDB array routing can also be used to generate a request. A single peripheral may generate multiple independent interrupt requests simplifying system and firmware design. Figure 7-10 shows the structure of the IDMUX (Interrupt/DMA Multiplexer).

Figure 7-10. Interrupt and DMA Processing in the IDMUX

Interrupt and DMA Processing in IDMUX



7.4.1 I/O Port Routing

There are a total of 20 DSI routes to a typical 8-bit I/O port, 16 for data and four for drive strength control.

When an I/O pin is connected to the routing, there are two primary connections available, an input and an output. In conjunction with drive strength control, this can implement a bidirectional I/O pin. A data output signal has the option to be single synchronized (pipelined) and a data input signal has the option to be double synchronized. The synchronization clock is the system clock (see Figure 6-1). Normally all inputs from pins are synchronized as this is required if the CPU interacts with the signal or any signal derived from it. Asynchronous inputs have rare uses. An example of this is a feed through of combinational PLD logic from input pins to output pins.

Figure 7-11. I/O Pin Synchronization Routing



Figure 7-12. I/O Pin Output Connectivity

8 IO Data Output Connections from the UDB Array Digital System Interface



There are four more DSI connections to a given I/O port to implement dynamic output enable control of pins. This connectivity gives a range of options, from fully ganged 8-bits controlled by one signal, to up to four individually controlled pins. The output enable signal is useful for creating tri-state bidirectional pins and buses.



8.2.3 Start of Conversion Input

The SoC signal is used to start an ADC conversion. A digital clock or UDB output can be used to drive this input. It can be used when the sampling period must be longer than the ADC conversion time or when the ADC must be synchronized to other hardware. This signal is optional and does not need to be connected if ADC is running in a continuous mode.

8.2.4 End of Conversion Output

The EoC signal goes high at the end of each ADC conversion. This signal may be used to trigger either an interrupt or DMA request.

8.3 Successive Approximation ADCs

The CY8C56LP family of devices has one or two Successive Approximation (SAR) ADCs, depending on device selected. These ADCs are 12-bit at up to 1 Msps, with single-ended or differential inputs, making them useful for a wide variety of sampling and control applications.

8.3.1 Functional Description

In a SAR ADC an analog input signal is sampled and compared with the output of a DAC. A binary search algorithm is applied to the DAC and used to determine the output bits in succession from MSB to LSB. A block diagram of one SAR ADC is shown in Figure 8-5.

Figure 8-5. SAR ADC Block Diagram



The input is connected to the analog globals and muxes. The frequency of the clock is 18 times the sample rate; the clock rate ranges from 1 to 18 MHz.

8.3.2 Conversion Signals

Writing a start bit or assertion of a Start of Frame (SOF) signal is used to start a conversion. SOF can be used in applications where the sampling period is longer than the conversion time, or when the ADC needs to be synchronized to other hardware. This signal is optional and does not need to be connected if the SAR ADC is running in a continuous mode. A digital clock or UDB output can be used to drive this input. When the SAR is first powered up or awakened from any of the sleeping modes, there is a power up wait time of 10 µs before it is ready to start the first conversion.

When the conversion is complete, a status bit is set and the output signal End of Frame (EOF) asserts and remains asserted until the value is read by either the DMA controller or the CPU. The EOF signal may be used to trigger an interrupt or a DMA request.

8.3.3 Operational Modes

A ONE_SHOT control bit is used to set the SAR ADC conversion mode to either continuous or one conversion per SOF signal. DMA transfer of continuous samples, without CPU intervention, is supported.

8.4 Comparators

The CY8C56LP family of devices contains four comparators. Comparators have these features:

- Input offset factory trimmed to less than 5 mV
- Rail-to-rail common mode input range (V_{SSA} to V_{DDA})
- Speed and power can be traded off by using one of three modes: fast, slow, or ultra low power
- Comparator outputs can be routed to look up tables to perform simple logic functions and then can also be routed to digital blocks
- The positive input of the comparators may be optionally passed through a low pass filter. Two filters are provided
- Comparator inputs can be connections to GPIO, DAC outputs and SC block outputs

8.4.1 Input and Output Interface

The positive and negative inputs to the comparators come from the analog global buses, the analog mux line, the analog local bus and precision reference through multiplexers. The output from each comparator could be routed to any of the two input LUTs. The output of that LUT is routed to the UDB Digital System Interface.



9.2 SWD Interface

The SWD interface is the preferred alternative to the JTAG interface. It requires only two pins instead of the four or five needed by JTAG. SWD provides all of the programming and debugging features of JTAG at the same speed. SWD does not provide access to scan chains or device chaining. The SWD clock frequency can be up to 1/3 of the CPU clock frequency.

SWD uses two pins, either two of the JTAG pins (TMS and TCK) or the USBIO D+ and D- pins. The USBIO pins are useful for in system programming of USB solutions that would otherwise require a separate programming connector. One pin is used for the data clock and the other is used for data input and output.

SWD can be enabled on only one of the pin pairs at a time. This only happens if, within 8 µs (key window) after reset, that pin pair

(JTAG or USB) receives a predetermined acquire sequence of 1s and 0s. If the NVL latches are set for SWD (see Section 5.5), this sequence need not be applied to the JTAG pin pair. The acquire sequence must always be applied to the USB pin pair.

SWD is used for debugging or for programming the flash memory.

The SWD interface can be enabled from the JTAG interface or disabled, allowing its pins to be used as GPIO. Unlike JTAG, the SWD interface can always be reacquired on any device during the key window. It can then be used to reenable the JTAG interface, if desired. When using SWD or JTAG pins as standard GPIO, make sure that the GPIO functionality and PCB circuits do not interfere with SWD or JTAG use.



Figure 9-2. SWD Interface Connections between PSoC 5LP and Programmer

² Vdda must be greater than or equal to all other power supplies (Vddd, Vddio's) in PSoC 5.

For Power cycle mode Programming, XRES pin is not required. But the Host programmer must have the capability to toggle power (Vddd, Vdda, All Vddio's) to PSoC 5. This may typically require external interface circuitry to toggle power which will depend on the programming setup. The power supplies can be brought up in any sequence, however, once stable, VDDA must be greater than or equal to all other supplies.



11.2 Device Level Specifications

Specifications are valid for –40 °C \leq T_A \leq 105 °C and T_J \leq 120 °C, except where noted. Specifications are valid for 1.71 V to 5.5 V, except where noted. Unless otherwise specified, all charts and graphs show typical values.

11.2.1 Device Level Specifications

Table 11-2. DC Specifications

Parameter	Description	Conditions	s	Min	Тур	Max	Units
V _{DDA}	Analog supply voltage and input to analog core regulator	Analog core regulator	enabled	1.8	_	5.5	V
V _{DDA}	Analog supply voltage, analog regulator bypassed	Analog core regulator	disabled	1.71	1.8	1.89	V
	Digital supply voltage relative to V _{SSD}	Digital core regulator	onablod	1.8	_	V _{DDA} ^[17]	v
V _{DDD}	Digital supply voltage relative to v _{SSD}		enableu	_	-	V _{DDA} + 0.1 ^[19]	v
V _{DDD}	Digital supply voltage, digital regulator bypassed	Digital core regulator	disabled	1.71	1.8	1.89	V
V _{DDIO} ^[18]	I/O supply voltage relative to V _{SSIO}			1.71	-	V _{DDA} ^[17]	V
V DDIO ⁻	NO supply voltage relative to v _{SSIO}			_	-	V _{DDA} + 0.1 ^[19]	v
V _{CCA}	Direct analog core voltage input (Analog regulator bypass)	Analog core regulator	disabled	1.71	1.8	1.89	V
V _{CCD}	Direct digital core voltage input (Digital regulator bypass)	Digital core regulator	disabled	1.71	1.8	1.89	V
I _{DD} ^[20]	Active Mode						
:	Sum of digital and analog IDDD + IDDA. IDDIOX for I/Os not included.	$V_{DDX} = 2.7 V \text{ to } 5.5 V;$	T = -40 °C	-	1.9	3.8	mA
	INCluded. IMO enabled, bus clock and CPU clock enabled. CPU	$F_{CPU} = 3 \text{ MHz}^{2}$	T = 25 °C	_	1.9	3.8	
	executing complex program from flash.		T = 85 °C	-	2	3.8	
			T = 105 °C	_	2	3.8	
		$V_{DDX} = 2.7 V \text{ to } 5.5 V;$	T = -40 °C	-	3.1	5	
		$F_{CPU} = 6 \text{ MHz}$	T = 25 °C	_	3.1	5	
			T = 85 °C	-	3.2	5	
			T = 105 °C	_	3.2	5	
		$V_{DDX} = 2.7 V \text{ to } 5.5 V;$ $F_{CPU} = 12 \text{ MHz}^{[21]}$	T = -40 °C	-	5.4	7	
			T = 25 °C	_	5.4	7	
			T = 85 °C	_	5.6	7	
			T = 105 °C	_	5.6	7	
		V _{DDX} = 2.7 V to 5.5 V; F _{CPU} = 24 MHz ^[21]	T = -40 °C	_	8.9	10.5	
		$F_{CPU} = 24 \text{ MHz}^{(21)}$	T = 25 °C	_	8.9	10.5	
			T = 85 °C	_	9.1	10.5	
			T = 105 °C	_	9.1	10.5	
		V _{DDX} = 2.7 V to 5.5 V; F _{CPU} = 48 MHz ^[21]	T = –40 °C	_	15.5	17	
		$F_{CPU} = 48 \text{ MHz}^{2}$	T = 25 °C	-	15.4	17	
			T = 85 °C	_	15.7	17	
			T = 105 °C	_	15.7	17.25	
		$V_{DDX} = 2.7 V \text{ to } 5.5 V;$	T = –40 °C	_	18	19.5	
		$F_{CPU} = 62 \text{ MHz}$	T = 25 °C	_	18	19.5	
			T = 85 °C	_	18.5	19.5	
			T = 105 °C	_	19	21	
		V _{DDX} = 2.7 V to 5.5 V;	T = -40 °C	_	26.5	30	
		$F_{CPU} = 74 \text{ MHz}$	T = 25 °C	_	26.5	30	
			T = 85 °C	_	27	30	
			T = 105 °C	_	27	30	
		V _{DDX} = 2.7 V to 5.5 V;	T = -40 °C	_	22	25.5	1
		V _{DDX} = 2.7 V to 5.5 V; F _{CPU} = 80 MHz, IMO = 3 MHz with PLL	T = 25 °C	-	22	25.5	1
			T = 85 °C	_	22.5	25.5	
			T = 105 °C	_	22.5	25.5	1

Notes

17. The power supplies can be brought up in any sequence however once stable V_{DDA} must be greater than or equal to all other supplies. 18. The V_{DDIO} supply voltage must be greater than the maximum voltage on the associated GPIO pins. Maximum voltage on GPIO pin $\leq V_{DDIO} \leq V_{DDA}$. 19. Guaranteed by design, not production tested.

20. The current consumption of additional peripherals that are implemented only in programmed logic blocks can be found in their respective datasheets, available in PSoC Creator, the integrated design environment. To estimate total current, find CPU current at frequency of interest and add peripheral currents for your particular system from the device datasheet and component datasheets.

21. Based on device characterization (Not production tested).



Table 11-2. DC Specifications (continued)

Parameter	Description	Condition	S	Min	Тур	Max	Units
I _{DD} ^[22]	Sleep Mode ^[23]						
		V _{DD} = V _{DDIO} = 4.5–5.5 V	T = -40 °C	_	1.9	3.1	μA
		4.5–5.5 V	T = 25 °C	_	2.4	3.6	
			T = 85 °C	_	5	16	
	CPU = OFF RTC = ON (= ECO32K ON in low-power mode)		T = 105 °C	_	5	16	
	RTC = ON (= ECO32K ON, in low-power mode) Sleep timer = ON (= ILO ON at 1 kHz) ^[24]	V _{DD} = V _{DDIO} = 2.7–3.6 V	T = -40 °C	_	1.7	3.1	
	WDT = OFF I ² C Wake = OFF	2.7–3.6 V	T = 25 °C	_	2	3.6	
	Comparator = OFF		T = 85 °C	-	4.2	16	
	POR = ON		T = 105 °C	_	4.2	16	
	Boost = OFF SIO pins in single ended input, unregulated output mode	V _{DD} = V _{DDIO} = 1.71–1.95 V	T = -40 °C	_	1.6	3.1	
		1.71–1.95 V	T = 25 °C	-	1.9	3.6	
		T =	T = 85 °C	-	4.2	16	
			T = 105 °C	_	4.2	16	
	Comparator = ON CPU = OFF RTC = OFF Sleep timer = OFF WDT = OFF I2C Wake = OFF POR = ON Boost = OFF SIO pins in single ended input, unregulated output mode	V _{DD} = V _{DDD} = 2.7–3.6 V ^[29]	T = 25 °C	_	3	4.2	μA
	I2C Wake = ON CPU = OFF RTC = OFF Sleep timer = OFF WDT = OFF Comparator = OFF POR = ON Boost = OFF SIO pins in single ended input, unregulated output mode	V _{DD} = V _{DDD} = 2.7-3.6 V ^[29]	T = 25 °C	_	1.7	3.6	μΑ

Notes

25. Based on device characterization (Not production tested).

 ^{22.} The current consumption of additional peripherals that are implemented only in programmed logic blocks can be found in their respective datasheets, available in PSoC Creator, the integrated design environment. To estimate total current, find CPU current at frequency of interest and add peripheral currents for your particular system from the device datasheet and component datasheets.
 23. If V_{CCD} and V_{CCA} are externally regulated, the voltage difference between V_{CCD} and V_{CCA} must be less than 50 mV.
 24. Sleep timer generates periodic interrupts to wake up the CPU. This specification applies only to those times that the CPU is off.





11.4 Inputs and Outputs

Specifications are valid for –40 °C \leq T_A \leq 105 °C and T_J \leq 120 °C, except where noted. Specifications are valid for 1.71 V to 5.5 V, except where noted. Unless otherwise specified, all charts and graphs show typical values.

When the power supplies ramp up, there are low-impedance connections between each GPIO pin and its V_{DDIO} supply. This causes the pin voltages to track V_{DDIO} until both V_{DDIO} and V_{DDA} reach the IPOR voltage, which can be as high as 1.45 V. At that point the low-impedance connections no longer exist, and the pins change to their normal NVL settings.

Also, if V_{DDA} is less than V_{DDIO} , a low-impedance path may exist between a GPIO and V_{DDA} , causing the GPIO to track V_{DDA} until V_{DDA} becomes greater than or equal to V_{DDIO} .

11.4.1 GPIO

Table 11-8. GPIO DC Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
V _{IH}	Input voltage high threshold	CMOS Input, PRT[x]CTL = 0	$0.7 \times V_{DDIO}$	_	-	V
V _{IL}	Input voltage low threshold	CMOS Input, PRT[x]CTL = 0	_	-	$0.3 \times V_{DDIO}$	V
V _{IH}	Input voltage high threshold	LVTTL Input, PRT[x]CTL = 1,V _{DDIO} < 2.7 V	0.7 x V _{DDIO}	I	-	V
V _{IH}	Input voltage high threshold	LVTTL Input, PRT[x]CTL = 1, $V_{DDIO} \ge 2.7 \text{ V}$	2.0	I	-	V
V _{IL}	Input voltage low threshold	LVTTL Input, PRT[x]CTL = 1,V _{DDIO} < 2.7 V	_	I	$0.3 \times V_{DDIO}$	V
V _{IL}	Input voltage low threshold	LVTTL Input, PRT[x]CTL = 1, $V_{DDIO} \ge 2.7 V$	_	I	0.8	V
V _{OH}	Output voltage high	I _{OH} = 4 mA at 3.3 V _{DDIO}	V _{DDIO} – 0.6	I	-	V
		I _{OH} = 1 mA at 1.8 V _{DDIO}	$V_{DDIO} - 0.5$	1	-	V
V _{OL}	Output voltage low	I _{OL} = 8 mA at 3.3 V _{DDIO}	-	1	0.6	V
		I _{OL} = 3 mA at 3.3 V _{DDIO}	-	I	0.4	V
		I _{OL} = 4 mA at 1.8 V _{DDIO}	-	I	0.6	V
Rpullup	Pull up resistor		3.5	5.6	8.5	kΩ
Rpulldown	Pull down resistor		3.5	5.6	8.5	kΩ
I _{IL}	Input leakage current (absolute value) ^[34]	25 °C, V _{DDIO} = 3.0 V	-	Ι	2	nA
C _{IN}	Input capacitance ^[34]	P0.0, P0.1, P0.2, P3.6, P3.7	_	17	20	pF
		P0.3, P0.4, P3.0, P3.1, P3.2	_	10	15	pF
		P0.6, P0.7, P15.0, P15.6, P15.7 ^[35]	_	7	12	pF
		All other GPIOs	_	5	9	pF
V _H	Input voltage hysteresis (Schmitt–Trigger) ^[34]		-	40	-	mV
Idiode	Current through protection diode to V_{DDIO} and V_{SSIO}		-	Ι	100	μA
Rglobal	Resistance pin to analog global bus	25 °C, V _{DDIO} = 3.0 V	-	320	-	Ω
Rmux	Resistance pin to analog mux bus	25 °C, V _{DDIO} = 3.0 V	-	220	-	Ω

Notes

34. Based on device characterization (Not production tested).

35. For information on designing with PSoC oscillators, refer to the application note, AN54439 - PSoC® 3 and PSoC 5 External Oscillator.



Figure 11-15. GPIO Output High Voltage and Current





Table 11-9. GPIO AC Specifications^[36]

Parameter	Description	Conditions	Min	Тур	Max	Units
TriseF	Rise time in Fast Strong Mode	3.3 V V _{DDIO} Cload = 25 pF	-	-	6	ns
TfallF	Fall time in Fast Strong Mode	$3.3 \text{ V} \text{ V}_{\text{DDIO}} \text{ Cload} = 25 \text{ pF}$	-	_	6	ns
TriseS	Rise time in Slow Strong Mode	$3.3 \text{ V} \text{ V}_{\text{DDIO}} \text{ Cload} = 25 \text{ pF}$	-	-	60	ns
TfallS	Fall time in Slow Strong Mode	$3.3 \text{ V V}_{\text{DDIO}}$ Cload = 25 pF	_	-	60	ns
118115	GPIO output operating frequency					
	$2.7 \text{ V} \leq \text{V}_{\text{DDIO}} \leq 5.5 \text{ V}$, fast strong drive mode	$3.3 \vee V_{DDIO}$ Cload = 25 pF - - 6 $3.3 \vee V_{DDIO}$ Cload = 25 pF - - 6 $3.3 \vee V_{DDIO}$ Cload = 25 pF - - 60 $3.3 \vee V_{DDIO}$ Cload = 25 pF - - 60 $3.3 \vee V_{DDIO}$ Cload = 25 pF - - 60 $3.3 \vee V_{DDIO}$ Cload = 25 pF - - 60 00^{+} 90/10% V_{DDIO} into 25 pF - - 33 $00de$ 90/10% V_{DDIO} into 25 pF - - 20 $00de$ 90/10% V_{DDIO} into 25 pF - - 7	MHz			
TriseFRise time in Fast StrongTfallFFall time in Fast StrongTriseSRise time in Slow StrongTfallSFall time in Slow StrongGPIO output operating $2.7 V \le V_{DDIO} \le 5.5 V, 1$ 1.71 V $\le V_{DDIO} \le 5.5 V, 1$ 3.3 V $\le V_{DDIO} \le 5.5 V, 1$ 1.71 V $\le V_{DDIO} \le 3.3 V, 1$	$1.71 \text{ V} \leq \text{V}_{\text{DDIO}} < 2.7 \text{ V}$, fast strong drive mode	90/10% V _{DDIO} into 25 pF	-	-	20	MHz
	$3.3 \text{ V} \le \text{V}_{\text{DDIO}} \le 5.5 \text{ V}$, slow strong drive mode	90/10% V _{DDIO} into 25 pF	_	_	7	MHz
	$1.71 \text{ V} \leq \text{V}_{\text{DDIO}} < 3.3 \text{ V}$, slow strong drive mode	90/10% V _{DDIO} into 25 pF	_	-	6 60 60 33 20 7 3.5	MHz
Fgpioin	GPIO input operating frequency	90/10% V _{DDIO}	_	-	33	MHz

Figure 11-16. GPIO Output Low Voltage and Current



11.5.4 SAR ADC

Table 11-24. SAR ADC DC Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
	Resolution		_	-	12	bits
	Number of channels – single-ended		-	-	No of GPIO	
	Number of channels – differential	Differential pair is formed using a pair of neighboring GPIO.	_	-	No of GPIO/2	
	Monotonicity ^[47]		Yes	_	-	
Ge	Gain error ^[48]	External reference	-	-	±0.1	%
V _{OS}	Input offset voltage		_	_	±2	mV
I _{DD}	Current consumption ^[47]		-	-	1	mA
	Input voltage range – single-ended ^[47]		V _{SSA}	-	V _{DDA}	V
	Input voltage range – differential ^[47]		V _{SSA}	-	V _{DDA}	V
PSRR	Power supply rejection ratio ^[47]		70	-	-	dB
CMRR	Common mode rejection ratio		70	-	-	dB
INL	Integral non linearity ^[47]	V _{DDA} 1.71 to 5.5 V, 1 Msps, V _{REF} 1 to 5.5 V, bypassed at ExtRef pin	-	-	+2/-1.5	LSB
		V _{DDA} 2.0 to 3.6 V, 1 Msps, V _{REF} 2 to V _{DDA, bypassed} at ExtRef pin	-	-	±1.2	LSB
		V _{DDA} 1.71 to 5.5 V, 500 ksps, V _{REF} 1 to 5.5 V, bypassed at ExtRef pin	-	-	±1.3	LSB
DNL	Differential non linearity ^[47]	V _{DDA} 1.71 to 5.5 V, 1 Msps, V _{REF} 1 to 5.5 V, bypassed at ExtRef pin	-	-	+2/–1	LSB
		V _{DDA} 2.0 to 3.6 V, 1 Msps, V _{REF} 2 to V _{DDA} , bypassed at ExtRef pin No missing codes	-	-	1.7/-0.99	LSB
		V _{DDA} 1.71 to 5.5 V, 500 ksps, V _{REF} 1 to 5.5 V, bypassed at ExtRef pin No missing codes	_	_	+2/-0.99	LSB
R _{IN}	Input resistance ^[47]		-	180	-	kΩ

Notes
47. Based on device characterization (Not production tested).
48. For total analog system Idd < 5 mA, depending on package used. With higher total analog system currents it is recommended that the SAR ADC be used in differential mode.

Figure 11-42. IDAC INL vs Input Code, Range = 255 μ A, Source Mode



Figure 11-44. IDAC DNL vs Input Code, Range = 255 μ A, Source Mode



Figure 11-46. IDAC INL vs Temperature, Range = 255 $\mu A,$ Fast Mode



Figure 11-43. IDAC INL vs Input Code, Range = 255 $\mu\text{A},$ Sink Mode







Figure 11-47. IDAC DNL vs Temperature, Range = 255 μ A, Fast Mode



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Table 11-42. LCD Direct Drive AC Specifications^[63]

Parameter	Description	Conditions	Min	Тур	Max	Units
f _{LCD}	LCD frame rate		10	50	150	Hz

11.6 Digital Peripherals

Specifications are valid for -40 $^{\circ}C \le T_A \le 105 ^{\circ}C$ and $T_J \le 120 ^{\circ}C$, except where noted. Specifications are valid for 1.71 V to 5.5 V, except where noted.

11.6.1 Timer

The following specifications apply to the Timer/Counter/PWM peripheral in timer mode. Timers can also be implemented in UDBs; for more information, see the Timer component datasheet in PSoC Creator.

Table 11-43. Timer DC Specifications^[63]

Parameter	Description	Conditions	Min	Тур	Max	Units
	Block current consumption	16-bit timer, at listed input clock frequency	-	-	-	μA
	3 MHz		_	15	-	μA
	12 MHz		_	60	-	μA
	48 MHz		_	260	_	μA
	80 MHz		-	360	-	μA

Table 11-44. Timer AC Specifications^[63]

Parameter	Description	Conditions	Min	Тур	Max	Units
	Operating frequency		DC	-	80.01	MHz
	Capture pulse width (Internal) ^[64]		15	_	_	ns
	Capture pulse width (external)		30	-	_	ns
	Timer resolution ^[64]		15	-	_	ns
	Enable pulse width ^[64]		15	_	_	ns
	Enable pulse width (external)		30	-	_	ns
	Reset pulse width ^[64]		15	-	-	ns
	Reset pulse width (external)		30	-	-	ns

11.6.2 Counter

The following specifications apply to the Timer/Counter/PWM peripheral, in counter mode. Counters can also be implemented in UDBs; for more information, see the Counter component datasheet in PSoC Creator.

Table 11-45. Counter DC Specifications^[63]

Parameter	Description	Conditions	Min	Тур	Max	Units
	Block current consumption	16-bit counter, at listed input clock frequency	-	-	-	μA
	3 MHz		-	15	-	μA
	12 MHz		-	60	-	μA
	48 MHz		-	260	-	μA
	80 MHz		_	360	_	μA

Notes

 ^{63.} Based on device characterization (Not production tested).
 64. For correct operation, the minimum Timer/Counter/PWM input pulse width is the period of bus clock.

11.7.5 External Memory Interface

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Figure 11-72. Asynchronous Write and Read Cycle Timing, No Wait States

Parameter	Description	Conditions	Min	Тур	Max	Units
Fbus_clock	Bus clock frequency ^[73]		-	-	33	MHz
Tbus_clock	Bus clock period ^[74]		30.3	-	-	ns
Twr_Setup	Time from EM_data valid to rising edge of EM_WE and EM_CE		Tbus_clock – 10	_	-	ns
Trd_setup	Time that EM_data must be valid before rising edge of EM_OE		5	_	-	ns
Trd_hold	Time that EM_data must be valid after rising edge of EM_OE		5	_	-	ns

Notes

72. Based on device characterization (Not production tested).

73. EMIF signal timings are limited by GPIO frequency limitations. See "GPIO" section on page 75.

74. EMIF output signals are generally synchronized to bus clock, so EMIF signal timings are dependent on bus clock frequency.



11.9.2 Internal Low-Speed Oscillator

Table 11-77. ILO DC Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
	Operating current ^[89]	F _{OUT} = 1 kHz	_	_	1.7	μA
I _{CC}		F _{OUT} = 33 kHz	-	-	2.6	μA
		F _{OUT} = 100 kHz	-	_	2.6	μA
	Leakage current ^[89]	Power down mode	-	_	15	nA

Table 11-78. ILO AC Specifications^[90]

Parameter	Description	Conditions	Min	Тур	Max	Units
Tstart_ilo	Startup time, all frequencies	Turbo mode	-	-	2	ms
	ILO frequencies					
F _{ILO}	100 kHz		45	100	200	kHz
	1 kHz		0.5	1	2	kHz

Figure 11-79. ILO Frequency Variation vs. Temperature



Figure 11-80. ILO Frequency Variation vs. V_{DD}



Notes

89. This value is calculated, not measured.
 90. Based on device characterization (Not production tested).



Acronym	Description
PHUB	peripheral hub
PHY	physical layer
PICU	port interrupt control unit
PLA	programmable logic array
PLD	programmable logic device, see also PAL
PLL	phase-locked loop
PMDD	package material declaration datasheet
POR	power-on reset
PRES	precise low-voltage reset
PRS	pseudo random sequence
PS	port read data register
PSoC [®]	Programmable System-on-Chip™
PSRR	power supply rejection ratio
PWM	pulse-width modulator
RAM	random-access memory
RISC	reduced-instruction-set computing
RMS	root-mean-square
RTC	real-time clock
RTL	register transfer language
RTR	remote transmission request
RX	receive
SAR	successive approximation register
SC/CT	switched capacitor/continuous time
SCL	I ² C serial clock
SDA	I ² C serial data
S/H	sample and hold
SIO	special input/output, GPIO with advanced features. See GPIO.
SNR	signal-to-noise ratio
SOC	start of conversion
SOF	start of frame
SPI	Serial Peripheral Interface, a communications protocol
SR	slew rate
SRAM	static random access memory
SRES	software reset
SWD	serial wire debug, a test protocol
SWV	single-wire viewer
TD	transaction descriptor, see also DMA
THD	total harmonic distortion

Table 14-1. Acronyms Used in this Document (continued)

Table 14-1. Acronyms Used in this Document (continued)

Acronym	Description
TIA	transimpedance amplifier
TRM	technical reference manual
TTL	transistor-transistor logic
TX	transmit
UART	Universal Asynchronous Transmitter Receiver, a communications protocol
UDB	universal digital block
USB	Universal Serial Bus
USBIO	USB input/output, PSoC pins used to connect to a USB port
VDAC	voltage DAC, see also DAC, IDAC
WDT	watchdog timer
WOL	write once latch, see also NVL
WRES	watchdog timer reset
XRES	external reset pin
XTAL	crystal



Document History Page (continued)

	Description Title: PSoC [®] 5LP: CY8C56LP Family Datasheet Programmable System-on-Chip (PSoC [®]) Document Number: 001-84935					
Revision	ECN	Orig. of Change	Submission Date	Description of Change		
*J	5030641	MKEA	11/30/2015	Added Table 2-1. Removed the configurable XRES information. Updated Section 5.6 Updated Section 6.3.1.1. Updated values for DSI Fmax, Fgpioin max, and Fsioin max. Corrected the web link for the PSoC 5 Device Programming Specifications in Section 9. Updated CSP Package Bootloader section. Added MHzECO DC Specifications. Updated 99-WLCSP and 100-pin TQFP package drawings. Added a footnote reference for the "CY8C5287AXI-LP095" part in Table 12-1 clarifying that it has 256 KB flash. Added the CY8C5667AXQ-LP040 part in Table 12-1.		
*K	5478402	MKEA	10/25/2016	Updated More Information. Add Links to CAD Libraries in Section 2. Corrected typos in External Electrical Connections.		
*L	5703770	GNKK	04/20/2017	Updated the Cypress logo and copyright information.		



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